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- Max $r_{DS(on)}$ =105m Ω at V_{GS} = -10V, I_D = -2.9A
- Max $r_{DS(on)}$ =135m Ω at V_{GS} = -4.5V, I_D = -2.5A
- Qualified to AEC Q101

FAIRCHILD

RoHS Compliant



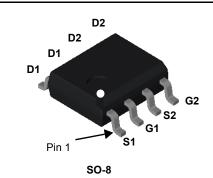
General Description

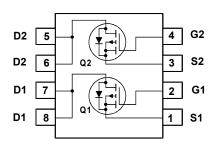
These P-channel logic level specified MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench[®] process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

These devices are well suited for portable electronics applications: load switching and power management, battery charging and protection circuits.

Applications

- Load Switch
- Power Management





MOSFET Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter	Ratings	Units		
V _{DS}	Drain to Source Voltage		-60	V	
V _{GS}	Gate to Source Voltage		±20	V	
I _D	Drain Current -Continuous	(Note 1a)	-2.9	•	
	-Pulsed		-12	A	
E _{AS}	Single Pulse Avalanche Energy	(Note 3)	54	mJ	
	Power Dissipation for Dual Operation		2		
PD	Power Dissipation	(Note 1a)	1.6	W	
	Power Dissipation	(Note 1b)	0.9		
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C	

Thermal Characteristics

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	40	°C/W
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient (Note 1a)	78	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDS9958	FDS9958_F085	SO-8	330mm	12mm	2500units

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January 2016

Cteristics Drain to Source Breakdown Voltage Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current Gate to Source Leakage Current	$\begin{split} I_{D} &= -250 \mu A, \ V_{GS} = 0 V \\ I_{D} &= -250 \mu A, \ referenced \ to \ 25^{\circ} C \\ V_{DS} &= -48 V, \\ V_{GS} &= 0 V \\ V_{GS} &= \pm 20 V, \ V_{DS} &= 0 V \\ \end{split}$	-60	-52	-1	V mV/°C
Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current	$I_D = -250 \mu A$, referenced to 25°C $V_{DS} = -48V$,	-60	-52	-1	
Coefficient Zero Gate Voltage Drain Current	$I_D = -250 \mu A$, referenced to 25°C $V_{DS} = -48V$,		-52	-1	mV/°C
Zero Gate Voltage Drain Current	V _{DS} = -48V,		-52	-1	mv/ O
-				-1	
Gate to Source Leakage Current				-100	μA
	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA
teristics					
	$V_{CS} = V_{DS}$. In = -250µA	-1.0	-1.6	-3.0	V
Gate to Source Threshold Voltage				2.0	-
Temperature Coefficient	$I_D = -250 \mu A$, referenced to 25°C		4		mV/°C
Static Drain to Source On Resistance	V _{GS} = -10V, I _D = -2.9A		82	105	
	V_{GS} = -4.5V, I_{D} = -2.5A		103	135	mΩ
			131	190	
Forward Transconductance	$V_{DD} = -5V, I_D = -2.9A$		7.7		S
Characteristics					
Input Capacitance	$V_{\rm DS} = -30V, V_{\rm GS} = 0V,$		765	1020	pF
Output Capacitance			90	120	pF
Reverse Transfer Capacitance			40	65	pF
Characteristics					
			6	12	ns
Rise Time			3	10	ns
Turn-Off Delay Time	$-V_{GS} = -10V, R_{GEN} = 6\Omega$		27	43	ns
Fall Time			6	12	ns
Total Gate Charge	V _{GS} = 0V to -10V		16	23	nC
Total Gate Charge	$V_{GS} = 0V \text{ to } -4.5V$ $V_{DD} = -30V,$		8	12	nC
Gate to Source Charge	I _D = -2.9A		2		nC
Gate to Drain "Miller" Charge			3		nC
rce Diode Characteristics					
			0.0	10	V
Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_{S} = -1.3A$ (Note 2)		-0.8	-1.2	v
Source to Drain Diode Forward Voltage Reverse Recovery Time	$V_{GS} = 0V, I_S = -1.3A$ (Note 2) $-I_F = -2.9A, di/dt = 100A/\mu s$		-0.8 26	-1.2 42	ns
	Temperature Coefficient Static Drain to Source On Resistance Forward Transconductance Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge	Gate to Source Threshold Voltage Temperature Coefficient $I_D = -250\mu$ A, referenced to 25°CStatic Drain to Source On Resistance $V_{GS} = -10V, I_D = -2.9A$ Static Drain to Source On Resistance $V_{GS} = -4.5V, I_D = -2.9A$ Forward Transconductance $V_{DD} = -5V, I_D = -2.9A$ Forward Transconductance $V_{DD} = -5V, I_D = -2.9A$ CharacteristicsInput Capacitance $V_{DS} = -30V, V_{GS} = 0V, f = 1MHz$ Reverse Transfer Capacitance $V_{DS} = -30V, V_{GS} = 0V, f = 1MHz$ Turn-On Delay Time $V_{DD} = -30V, I_D = -2.9A, V_{GS} = -10V, R_{GEN} = 6\Omega$ Turn-Off Delay Time $V_{GS} = 0V \text{ to } -10V, V_{GS} = 0V \text{ to } -2.9A, V_{GS} = -30V, I_D = -2.9A, V_{GS} = -2.9A, V_{GS} = -10V, R_{GEN} = 6\Omega$ Total Gate Charge $V_{GS} = 0V \text{ to } -4.5V, I_D = -2.9A, I_D = -2.9A, V_{DD} = -30V, I_D = -2.9A, V_{GS} = -30V, I_D = -2.9A, V_{GS} = -30V, I_D = -2.9A, V_{GS} = -2.9A, V_{GS} = -10V, R_{GEN} = 6\Omega$ Total Gate Charge $V_{GS} = 0V \text{ to } -4.5V, I_D = -2.9A, I_D = -2.9A, I_D = -2.9A, V_{GS} = -2.9A, I_D = -2.9$	Gate to Source Threshold Voltage Temperature Coefficient $I_D = -250\mu A$, referenced to $25^{\circ}C$ Static Drain to Source On Resistance $V_{GS} = -10V, I_D = -2.9A$ Static Drain to Source On Resistance $V_{GS} = -10V, I_D = -2.9A$ Forward Transconductance $V_{DD} = -5V, I_D = -2.9A$ Forward Transconductance $V_{DD} = -5V, I_D = -2.9A$ Characteristics $V_{DS} = -30V, V_{GS} = 0V, f = 1MHz$ Input Capacitance Output Capacitance $V_{DS} = -30V, V_{GS} = 0V, f = 1MHz$ Reverse Transfer Capacitance $V_{DD} = -30V, I_D = -2.9A, V_{GS} = 0V, f = 1MHz$ Turn-On Delay Time Fail Time $V_{DD} = -30V, I_D = -2.9A, V_{GS} = -10V, R_{GEN} = 6\Omega$ Total Gate Charge Gate to Source Charge $V_{GS} = 0V \text{ to } -10V, I_D = -2.9A, I_D = -2.9A,$	$ \begin{array}{c c} \mbox{Gate to Source Threshold Voltage Temperature Coefficient} & I_D = -250 \mu A, referenced to 25°C & 4 \\ I_D = -250 \mu A, referenced to 25°C & 4 \\ \hline V_{GS} = -10V, I_D = -2.9A & 82 \\ \hline V_{GS} = -4.5V, I_D = -2.9A & 103 \\ \hline V_{GS} = -10V, I_D = -2.9A, T_J = 125°C & 131 \\ \hline V_{DD} = -5V, I_D = -2.9A & 7.7 \\ \hline \end{tabular} $	$ \begin{array}{c c c c c c } \hline Gate to Source Threshold Voltage Temperature Coefficient & I_D = -250 \mu A, referenced to 25°C & 4 & \\ \hline I_D = -250 \mu A, referenced to 25°C & 4 & \\ \hline V_{GS} = -10V, \ I_D = -2.9A & 82 & 105 & \\ \hline V_{GS} = -4.5V, \ I_D = -2.9A, \ T_J = 125°C & 131 & 190 & \\ \hline V_{GS} = -10V, \ I_D = -2.9A, \ T_J = 125°C & 131 & 190 & \\ \hline Forward Transconductance & V_{DD} = -5V, \ I_D = -2.9A & 7.7 & \\ \hline \mbox{Characteristics} & & & & & & & & & \\ \hline Input Capacitance & V_{DD} = -5V, \ I_D = -2.9A & & & & & & & & & \\ \hline Input Capacitance & V_{DS} = -30V, \ V_{GS} = 0V, \ f = 1MHz & & & & & & & & & & & & \\ \hline \mbox{Characteristics} & & & & & & & & & & & & & & \\ \hline \mbox{Characteristics} & & & & & & & & & & & & & & & & & \\ \hline \mbox{Characteristics} & & & & & & & & & & & & & & & & & & \\ \hline \mbox{Characteristics} & & & & & & & & & & & & & & & & & & \\ \hline \mbox{Turn-On Delay Time} & & & & & & & & & & & & & & & & & & &$

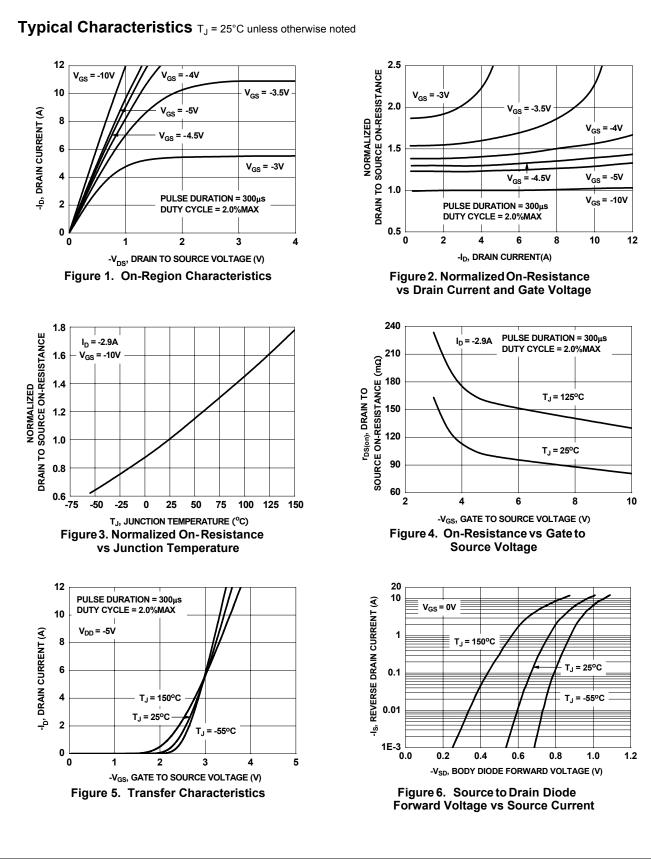
2. Pulse Test: Pulse Width < 300μ s, Duty cycle < 2.0%.

3. UIL condition: Starting T_J = 25°C, L = 3mH, I_{AS} = 6A, V_{DD} = 60V, V_{GS} = 10V.

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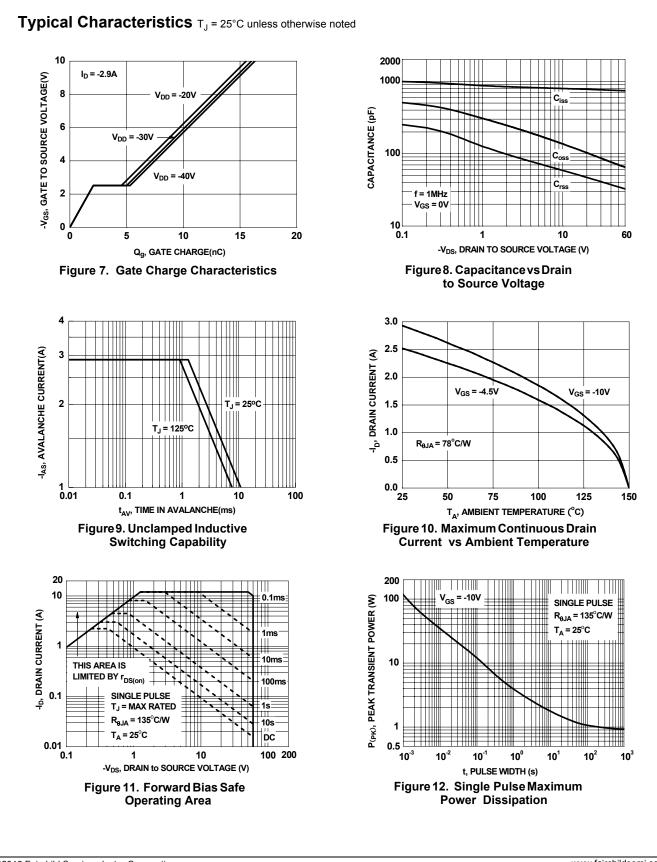
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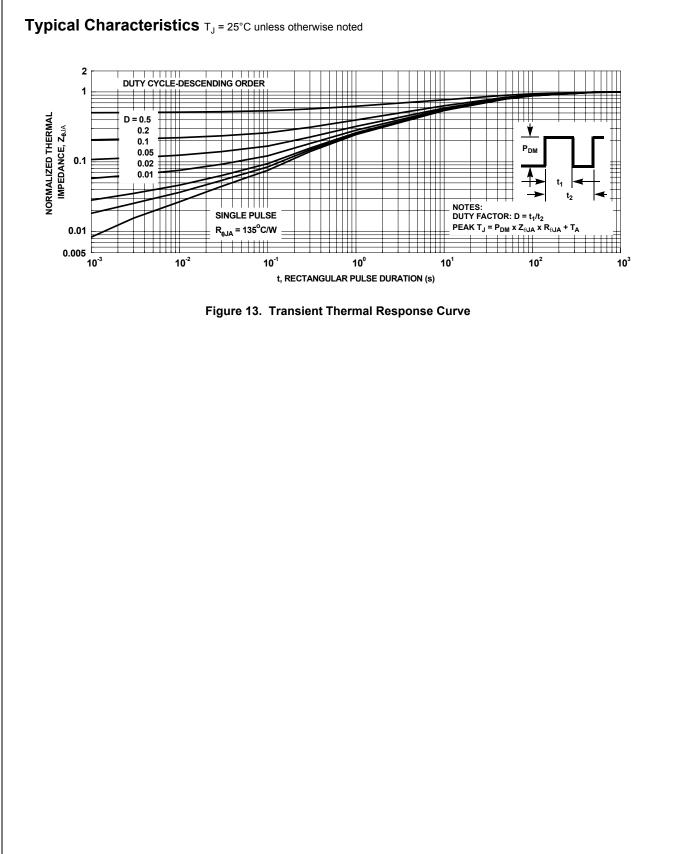
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